Power MOSFET

30 V, 46 A, Single N-Channel, μ8FL

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Low-Side DC-DC Converters
- Power Load Switch
- Notebook Battery Management
- Motor Control

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

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Param	neter		Symbol	Value	Unit
Drain-to-Source Voltage	Drain-to-Source Voltage				V
Gate-to-Source Voltage			V_{GS}	±20	V
Continuous Drain		T _A = 25°C	I _D	13.5	Α
Current R _{θJA} (Note 1)		T _A = 85°C	1	9.7	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	2.19	W
Continuous Drain		T _A = 25°C	I _D	19	Α
Current R _{θJA} ≤ 10 s (Note 1)		T _A = 85°C		13.7	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C	P _D	4.42	W
Continuous Drain	State	T _A = 25°C	I _D	8.3	Α
Current R _{θJA} (Note 2)		T _A = 85°C		6.0	
Power Dissipation $R_{\theta JA}$ (Note 2)		T _A = 25°C	P _D	0.84	W
Continuous Drain		T _C = 25°C	I _D	46	Α
Current R _{θJC} (Note 1)		T _C = 85°C		33	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	25.5	W
Pulsed Drain Current	$T_{A} = 25^{\circ}$	C, t _p = 10 μs	I _{DM}	140	Α
Operating Junction and S	Operating Junction and Storage Temperature				°C
Source Current (Body Did	I _S	29	Α		
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain-to-So $(T_J=25^{\circ}C,V_{DD}=50V,V_{L}=29A_{pk},L=0.1$ mH, F	E _{AS}	42	mJ		
Lead Temperature for So (1/8" from case for 10 s)	TL	260	°C		

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface–mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

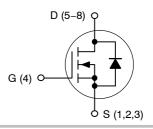


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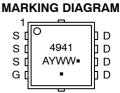
V _{(BR)DSS} R _{DS(on)} MAX		I _D MAX
30 V	6.2 mΩ @ 10 V	46 A
	9.0 mΩ @ 4.5 V	407

N-Channel MOSFET





WDFN8 (μ8FL) CASE 511AB



4941 = Specific Device Code = Assembly Location Α = Year WW = Work Week

= Pb-Free Package

ORDERING INFORMATION

(Note: Microdot may be in either location)

Device	Package	Shipping [†]
NTTFS4941NTAG	WDFN8 (Pb-Free)	1500/Tape & Reel
NTTFS4941NTWG	WDFN8 (Pb-Free)	5000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	4.9	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{ heta JA}$	57	
Junction-to-Ambient - Steady State (Note 4)	$R_{ heta JA}$	148	
Junction-to-Ambient – (t \leq 10 s) (Note 3)	$R_{ heta JA}$	28.3	

ELECTRICAL CHARACTERISTICS (T₁ = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				·•	•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				15		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	$T_{J} = 25^{\circ}C$ $T_{J} = 125^{\circ}C$			1.0 10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	s = ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)			<u> </u>		1		
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.2		2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.3		mV/°C
Drain-to-Source On Resistance	R _{DS(on)} V _{GS} = 10 V	\/	I _D = 20 A		4.8	6.2	mΩ
		I _D = 10 A		4.8			
		V 45V	I _D = 20 A		7.0	9.0	
		V _{GS} = 4.5 V	I _D = 10 A		7.0		
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _D = 15 A			33		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 15 V			1619		pF
Output Capacitance	C _{oss}				573		
Reverse Transfer Capacitance	C _{rss}				18		
Total Gate Charge	Q _{G(TOT)}				10.1		nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = ⁻	15 V I 20 A		2.6		
Gate-to-Source Charge	Q_{GS}	v _{GS} = 4.5 v, v _{DS} =	15 V, ID = 20 A		4.9		
Gate-to-Drain Charge	Q_{GD}				1.3		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 20 A			22.8		nC
SWITCHING CHARACTERISTICS (N	ote 6)						
Turn-On Delay Time	t _{d(on)}				11		ns
Rise Time	t _r	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			21		
Turn-Off Delay Time	t _{d(off)}				19		
Fall Time	t _f				3.0		

^{5.} Pulse Test: pulse width = 300 μ s, duty cycle \leq 2%.

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size (40 mm², 1 oz. Cu).

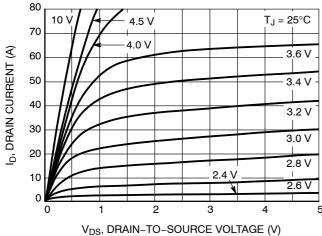
^{6.} Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

		<u> </u>	· ·		ī		
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS	S (Note 6)						
Turn-On Delay Time	t _{d(on)}				8.0		ns
Rise Time	t _r	V _{GS} = 10 V, V _{DS}	= 15 V,		20		
Turn-Off Delay Time	t _{d(off)}	$I_D = 15 \text{ A}, R_G =$			23		1
Fall Time	t _f	1			2.0		1
DRAIN-SOURCE DIODE CHARA	ACTERISTICS						-
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.87	1.2	V
		$I_S = 20 \text{ A}$	T _J = 125°C		0.75		1
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } d_{ S }/d_t = 100 \text{ A/}\mu\text{s,}$ $I_S = 20 \text{ A}$			30		ns
Charge Time	ta				16		1
Discharge Time	t _b				14		1
Reverse Recovery Charge	Q_{RR}				22		nC
PACKAGE PARASITIC VALUES							-
Source Inductance	L _S				0.38		nΗ
Drain Inductance	L _D	T _A = 25°C			0.054		1
Gate Inductance	L _G				1.3		1
Gate Resistance	R _G				1.1	2.0	Ω

^{5.} Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



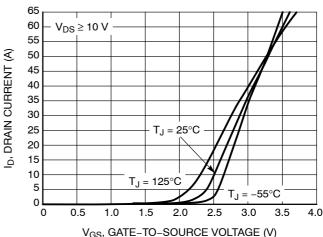
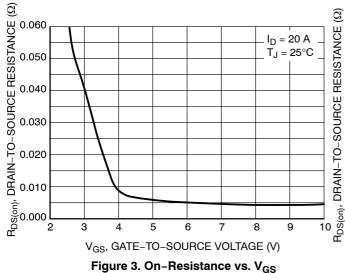


Figure 2. Transfer Characteristics

Figure 1. On-Region Characteristics



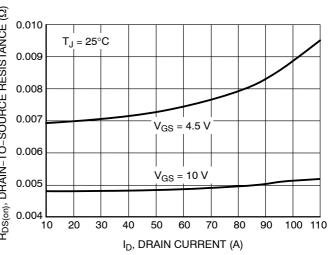


Figure 4. On-Resistance vs. Drain Current and **Gate Voltage**

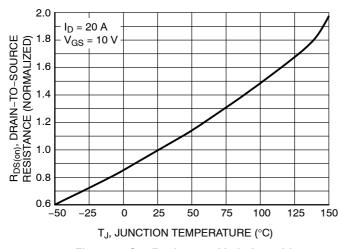


Figure 5. On-Resistance Variation with **Temperature**

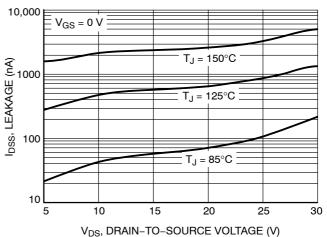


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

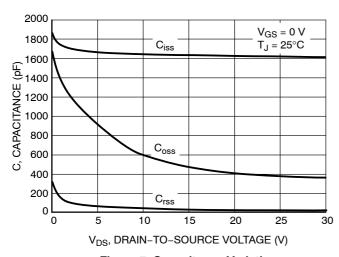


Figure 7. Capacitance Variation

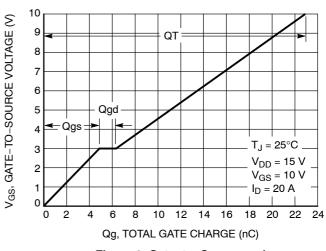


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

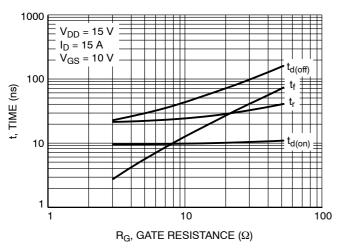


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

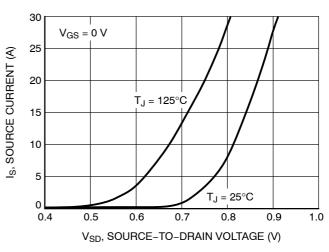


Figure 10. Diode Forward Voltage vs. Current

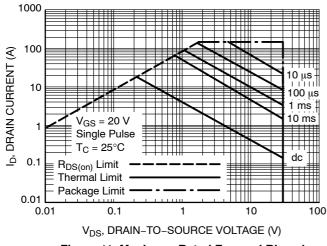


Figure 11. Maximum Rated Forward Biased Safe Operating Area

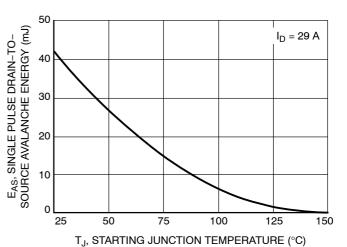


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL CHARACTERISTICS

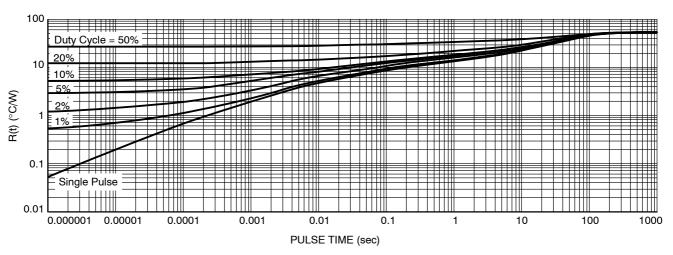
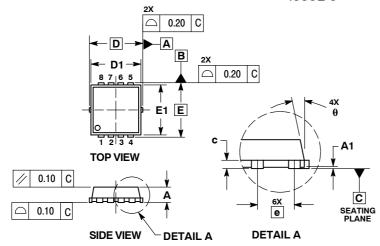


Figure 13. Thermal Response

PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P

CASE 511AB ISSUE C

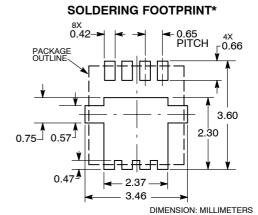


NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC		C	.130 BSC	;	
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
Е		3.30 BSC		0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е	0.65 BSC			0.026 BSC			
G	0.30	0.41	0.51	0.012	0.016	0.020	
K	0.64			0.025			
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0°		12°	0°		12°	

8X 0.10 C A B 0.05 C 4X L 4X L 4X L 6 BOTTOM VIEW



*For additional information on our Pb —Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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